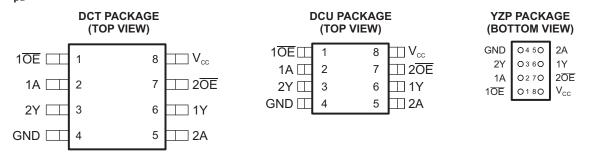
FEATURES

- Available in the Texas Instruments
 NanoFree[™] Package
- Optimized for 1.8-V Operation and Is 3.6-V I/O Tolerant to Support Mixed-Mode Signal Operation
- I_{off} Supports Partial-Power-Down Mode Operation
- Sub-1-V Operable
- Max t_{pd} of 1.8 ns at 1.8 V

- Low Power Consumption, 10 μA at 1.8 V
- ±8-mA Output Drive at 1.8 V
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)



See mechanical drawings for dimensions.

DESCRIPTION/ORDERING INFORMATION

This dual buffer/driver is operational at 0.8-V to 2.7-V V_{CC} , but is designed specifically for 1.65-V to 1.95-V V_{CC} operation.

The SN74AUC2G240 is designed specifically to improve the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters.

This device is organized as two 1-bit buffers/drivers with separate output-enable (\overline{OE}) inputs. When \overline{OE} is low, the device passes data from the A input to the Y output. When \overline{OE} is high, the outputs are in the high-impedance state.

NanoFree™ package technology is a major breakthrough in IC packaging concepts, using the die as the package.

To ensure the high-impedance state during power up or power down, $\overline{\text{OE}}$ should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

ORDERING INFORMATION

T _A	PACKAGE ⁽¹⁾		ORDERABLE PART NUMBER	TOP-SIDE MARKING ⁽²⁾
	NanoFree™ – WCSP (DSBGA) 0.23-mm Large Bump – YZP (Pb-free)	Reel of 3000	SN74AUC2G240YZPR	UK_
-40°C to 85°C	SSOP - DCT	Reel of 3000	SN74AUC2G240DCTR	U40
	VSSOP - DCU	Reel of 3000	SN74AUC2G240DCUR	UK_

⁽¹⁾ Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

⁽²⁾ DCT: The actual top-side marking has three additional characters that designate the year, month, and assembly/test site. DCU: The actual top-side marking has one additional character that designates the assembly/test site. YZP: The actual top-side marking has three preceding characters to denote year, month, and sequence code, and one following character to designate the assembly/test site. Pin 1 identifier indicates solder-bump composition (1 = SnPb, • = Pb-free).



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

NanoFree is a trademark of Texas Instruments.



DESCRIPTION/ORDERING INFORMATION (CONTINUED)

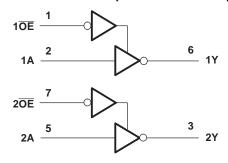
This device is fully specified for partial-power-down applications using I_{off} . The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

For more information about AUC Little Logic devices, please refer to the TI application report, *Applications of Texas Instruments AUC Sub-1-V Little Logic Devices*, literature number SCEA027.

FUNCTION TABLE (EACH BUFFER)

INP	JTS	OUTPUT Y				
ŌĒ	Α					
L	Н	L				
L	L	Н				
Н	X	Z				

LOGIC DIAGRAM (POSITIVE LOGIC)





SN74AUC2G240 **DUAL BUFFER/DRIVER** WITH 3-STATE OUTPUTS

Absolute Maximum Ratings(1)

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT	
V_{CC}	Supply voltage range		-0.5	3.6	V	
VI	Input voltage range ⁽²⁾	-0.5	3.6	V		
Vo	Voltage range applied to any output in the I	-0.5	3.6	V		
Vo	Output voltage range ⁽²⁾	-0.5	V _{CC} + 0.5	V		
I _{IK}	Input clamp current	V ₁ < 0		-50	mA	
I _{OK}	Output clamp current	V _O < 0		-50	mA	
Io	Continuous output current			±20	mA	
	Continuous current through V _{CC} or GND			±100	mA	
		DCT package		220		
θ_{JA}	Package thermal impedance (3)	DCU package		227	°C/W	
		YZP package		102		
T _{stg}	Storage temperature range		-65	150	°C	

Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

(3) The package thermal impedance is calculated in accordance with JESD 51-7.

Recommended Operating Conditions(1)

			MIN	MAX	UNIT	
V_{CC}	Supply voltage		0.8	2.7	V	
		V _{CC} = 0.8 V	V _{CC}			
V_{IH}	High-level input voltage	$V_{CC} = 1.1 \text{ V to } 1.95 \text{ V}$	$0.65 \times V_{CC}$		V	
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.7			
		V _{CC} = 0.8 V		0		
V_{IL}	Low-level input voltage	$V_{CC} = 1.1 \text{ V to } 1.95 \text{ V}$		$0.35 \times V_{CC}$	V	
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		0.7		
V_{I}	Input voltage		0	3.6	V	
V	Output voltage	Active state	0	V_{CC}	V	
Vo	Output voltage	3-state	0	3.6	V	
		$V_{CC} = 0.8 \text{ V}$		-0.7		
		V _{CC} = 1.1 V		-3		
I_{OH}	High-level output current	V _{CC} = 1.4 V		- 5	mA	
		V _{CC} = 1.65 V		-8		
		V _{CC} = 2.3 V		- 9		
		V _{CC} = 0.8 V		0.7		
		V _{CC} = 1.1 V		3		
I_{OL}	Low-level output current	V _{CC} = 1.4 V		5	mA	
		V _{CC} = 1.65 V		8		
		V _{CC} = 2.3 V		9		
		$V_{CC} = 0.8 \text{ V to } 1.65 \text{ V}^{(2)}$		20		
$\Delta t/\Delta v$	Input transition rise or fall rate	$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}^{(3)}$		20	ns/V	
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}^{(3)}$		20		
T _A	Operating free-air temperature		-40	85	°C	

⁽¹⁾ All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

⁽²⁾ The data was taken at $C_L = 15$ pF, $R_L = 2$ k Ω (see Figure 1). (3) The data was taken at $C_L = 30$ pF, $R_L = 500$ Ω (see Figure 1).



Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PAR	AMETER	TEST CONDITION	S	V _{cc}	MIN	TYP ⁽¹⁾	MAX	UNIT		
		$I_{OH} = -100 \mu A$		0.8 V to 2.7 V	V _{CC} - 0.1					
		$I_{OH} = -0.7 \text{ mA}$		0.8 V		0.55				
M		$I_{OH} = -3 \text{ mA}$		1.1 V	0.8			V		
V _{OH}		$I_{OH} = -5 \text{ mA}$		1.4 V	1			V		
		$I_{OH} = -8 \text{ mA}$		1.65 V	1.2					
		$I_{OH} = -9 \text{ mA}$								
		I _{OL} = 100 μA		0.8 V to 2.7 V			0.2			
		I _{OL} = 0.7 mA		0.8 V		0.25				
\/		I _{OL} = 3 mA		1.1 V			0.3	V		
V _{OL}		I _{OL} = 5 mA		1.4 V			0.4	V		
		I _{OL} = 8 mA		1.65 V			0.45			
		I _{OL} = 9 mA		2.3 V			0.6			
I _I A	or OE inputs	V _I = V _{CC} or GND		0 to 2.7 V			±5	μΑ		
I _{off}		V_I or $V_O = 2.7 V$		0			±10	μΑ		
I_{OZ}		V _O = V _{CC} or GND		2.7 V			±10	μΑ		
I _{CC}		$V_I = V_{CC}$ or GND,	$I_O = 0$	0.8 V to 2.7 V		·	10	μΑ		
C _i		V _I = V _{CC} or GND		2.5 V		2.5		pF		
C _o		V _O = V _{CC} or GND		2.5 V		5.5		pF		

⁽¹⁾ All typical values are at $T_A = 25$ °C.

Switching Characteristics

over recommended operating free-air temperature range, C_L = 15 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 0.8 V	V _{CC} = ± 0.	1.2 V 1 V		1.5 V .1 V		_C = 1.8 : 0.15 \		V _{CC} = ± 0.		UNIT
	(INPOT)	(001701)	TYP	MIN	MAX	MIN	MAX	MIN	TYP	MAX	MIN	MAX	
t _{pd}	Α	Υ	4.5	0.9	3.3	0.7	2.2	0.5	1.2	1.8	0.5	1.3	ns
t _{en}	ŌĒ	Υ	5.6	0.9	4.1	0.7	2.5	0.6	1.4	2.1	0.6	1.5	ns
t _{dis}	ŌĒ	Y	5.8	1.9	4.8	1.5	3.8	1.8	2.8	4	1.4	2.9	ns

Switching Characteristics

over recommended operating free-air temperature range, $C_L = 30 \text{ pF}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _C	V _{CC} = 1.8 V ± 0.15 V		V _{CC} = 1 ± 0.2	UNIT	
	(INPUT)	(001F01)	MIN	TYP	MAX	MIN	MAX	
t _{pd}	A	Υ	0.7	1.5	2.5	0.6	1.7	ns
t _{en}	ŌĒ	Υ	0.9	1.7	3.1	0.8	2.1	ns
t _{dis}	ŌĒ	Υ	1.5	1.8	3.7	0.8	1.9	ns

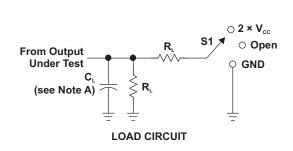
Operating Characteristics

 $T_A = 25^{\circ}C$

PARAMETER TEST CONDITIONS		V _{CC} = 0.8 V TYP	V _{CC} = 1.2 V TYP	V _{CC} = 1.5 V TYP	V _{CC} = 1.8 V TYP	V _{CC} = 2.5 V TYP	UNIT	
C _{pd}	Power dissipation capacitance	f = 10 MHz	15	15	15	15	17	pF

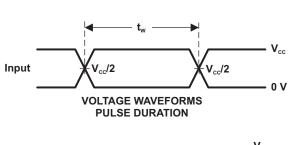


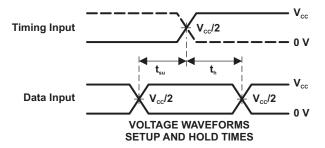
PARAMETER MEASUREMENT INFORMATION

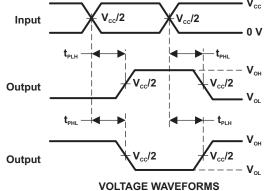


TEST	S1
t _{PLH} /t _{PHL}	Open
t_{PLZ}/t_{PZL}	2 × V _{cc}
t _{PHZ} /t _{PZH}	GND

V _{cc}	C _∟	R _L	V _Δ
0.8 V	15 pF	2 k Ω	0.1 V
1.2 V ± 0.1 V	15 pF	2 k Ω	0.1 V
$1.5 \ V \pm 0.1 \ V$	15 pF	2 k Ω	0.1 V
1.8 V ± 0.15 V	15 pF	2 k Ω	0.15 V
$2.5~V~\pm~0.2~V$	15 pF	2 k Ω	0.15 V
1.8 V ± 0.15 V	30 pF	1 k Ω	0.15 V
$2.5 V \pm 0.2 V$	30 pF	500 Ω	0.15 V
		I	I

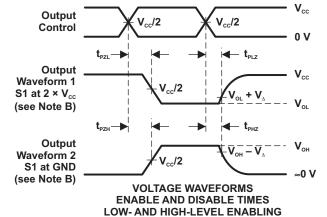






PROPAGATION DELAY TIMES

INVERTING AND NONINVERTING OUTPUTS



NOTES: A. C. includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z_o = 50 Ω, slew rate ≥ 1 V/ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. t_{PLZ} and \dot{t}_{PHZ} are the same as t_{dis} .
- F. t_{PZL} and t_{PZH} are the same as t_{en} .
- G. $t_{\text{\tiny PLH}}$ and $t_{\text{\tiny PHL}}$ are the same as $t_{\text{\tiny pd}}$.

Figure 1. Load Circuit and Voltage Waveforms





17-May-2014

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
74AUC2G240DCTRE4	ACTIVE	SM8	DCT	8		TBD	Call TI	Call TI	-40 to 85		Samples
74AUC2G240DCTRG4	ACTIVE	SM8	DCT	8		TBD	Call TI	Call TI	-40 to 85		Samples
74AUC2G240DCURE4	ACTIVE	US8	DCU	8		TBD	Call TI	Call TI	-40 to 85		Samples
74AUC2G240DCURG4	ACTIVE	US8	DCU	8		Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	U40R	Samples
SN74AUC2G240DCTR	ACTIVE	SM8	DCT	8	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	U40 Z	Samples
SN74AUC2G240DCUR	ACTIVE	US8	DCU	8	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	U40R	Samples
SN74AUC2G240YZPR	ACTIVE	DSBGA	YZP	8	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	UK7	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.



PACKAGE OPTION ADDENDUM

17-May-2014

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74AUC2G240DCUR	US8	DCU	8	3000	180.0	8.4	2.25	3.35	1.05	4.0	8.0	Q3

www.ti.com 11-Feb-2014



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74AUC2G240DCUR	US8	DCU	8	3000	202.0	201.0	28.0

DCT (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE

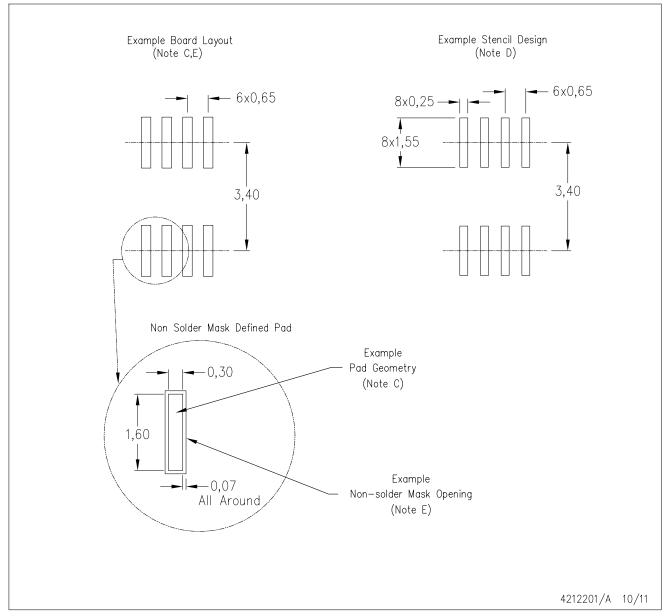


NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion
- D. Falls within JEDEC MO-187 variation DA.

DCT (R-PDSO-G8)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



DCU (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE (DIE DOWN)



NOTES:

- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
 - D. Falls within JEDEC MO-187 variation CA.



DCU (S-PDSO-G8)

PLASTIC SMALL OUTLINE PACKAGE (DIE DOWN)



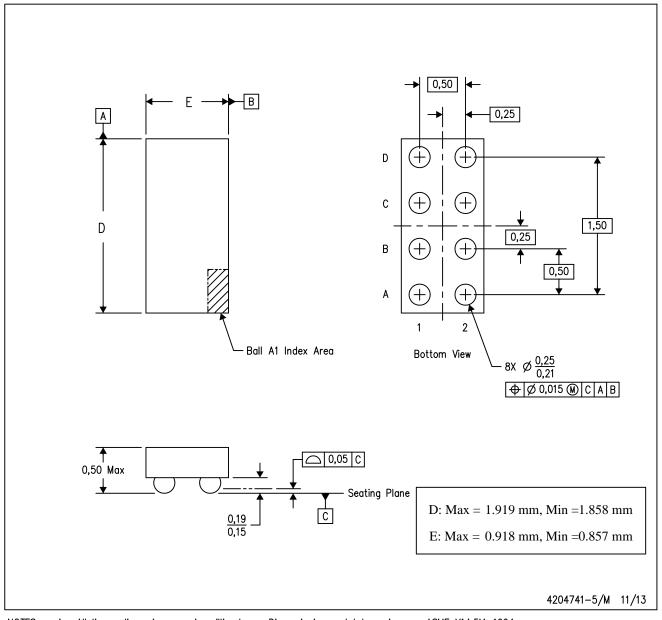
NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



YZP (R-XBGA-N8)

DIE-SIZE BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.

- B. This drawing is subject to change without notice.
- C. NanoFree™ package configuration.

NanoFree is a trademark of Texas Instruments.



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DSP **Energy and Lighting** dsp.ti.com www.ti.com/energy Clocks and Timers www.ti.com/clocks Industrial www.ti.com/industrial Interface interface.ti.com Medical www.ti.com/medical logic.ti.com Logic Security www.ti.com/security

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